


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599644	<b>Applicant(s)/Patent Under Reexamination</b>  PERNER, PETRA
	<b>Examiner</b>  PETER COUGHLAN	<b>Art Unit</b>  2129

### SEARCHED

Class	Subclass	Date	Examiner
411	344	5/21/2010	PDC

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor, Petra Perner	5/20/2010	PDC
Google -- Petra Perner, HEP-2, tracing, outline, classification	5/20/2010	PDC
IEEE -- Perner, HEP-2, classification	5/20/2010	PDC
East -- @pd<20040408 and manually, trace, outline, image, device, HEP-2, HEP2, HEP 2, pen, input, carrier, rotation, cell, indicate, chart, delineate, depict, record, sketch, manual, center, centroid, orient, distance matrix, intersect, similarity, origin, average, mean	5/21/2010	PDC
East -- @pd<20040408 and 706/20 w/"data mining"	5/21/2010	PDC

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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